

Search Notes



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Examiner

Hae M. Hyeon

Applicant(s)/Patent under Reexamination

SHIMIZU ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
Search	Updated	12/05	hnh

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
439	660	12/05	hnh
439	636	↓	↓

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Interference Search Done	12/05	hnh